


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595485	<b>Applicant(s)/Patent Under Reexamination</b>  GHIGO ET AL.
	<b>Examiner</b>  GYAN CHANDRA	<b>Art Unit</b>  1646

SEARCHED			
Class	Subclass	Date	Examiner
NONE	NONE	6/15/10	GC

SEARCH NOTES		
Search Notes	Date	Examiner
STIC search for SEQ ID NO: 1 against pending databases (see Search results in SCORE)	6/15/10	GC
Claims searched in EAST (see Enclosed document)	6/15/10	GC
Inventorship search in EAST(see Enclosed document)	6/15/10	GC
Inventorship search in PALM	6/15/10	GC
Pat. Conf. with SPE Nickol	6/14/2010	GC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
NONE	see Search Notes	6/15/10	GC

/GYAN CHANDRA/ Examiner.Art Unit 1646	
--	--